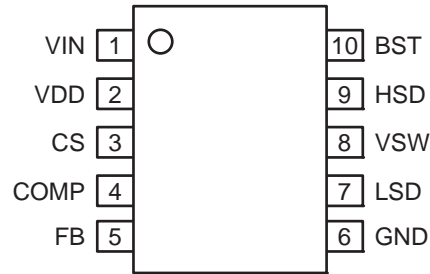


## Ordering Information

Part Number	Pb-Free Part Number	Frequency	Junction Temp. Range	Package
MIC2169BMM	MIC2169YMM	500kHz	-40°C to +125°C	10-lead MSOP

## Pin Configuration



10-Pin MSOP (MM)

## Pin Description

Pin Number	Pin Name	Pin Function
1	VIN	Supply Voltage (Input): 3V to 14.5V.
2	VDD	5V Internal Linear Regulator (Output): $V_{DD}$ is the external MOSFET gate drive supply voltage and an internal supply bus for the IC. When $V_{IN}$ is <5V, this regulator operates in dropout mode.
3	CS	Current Sense (Input): Current-limit comparator noninverting input. The current limit is sensed across the MOSFET during the ON time. The current can be set by the resistor in series with the CS pin.
4	COMP	Compensation (Input): Pin for external compensation. .
5	FB	Feedback (Input): Input to error amplifier. Regulates error amplifier to 0.8V.
6	GND	Ground (Return).
7	LSD	Low-Side Drive (Output): High-current driver output for external synchronous MOSFET.
8	VSW	Switch (Return): High-side MOSFET driver return.
9	HSD	High-Side Drive (Output): High-current output-driver for the high-side MOSFET. When $V_{IN}$ is between 3.0V to 5V, 2.5V threshold MOSFETs should be used. At $V_{IN} > 5V$ , 5V threshold MOSFETs should be used.
10	BST	Boost (Input): Provides the drive voltage for the high-side MOSFET driver. The gate-drive voltage is higher than the source voltage by $V_{IN}$ minus a diode drop.

**Absolute Maximum Ratings<sup>(1)</sup>**

Supply Voltage ( $V_{IN}$ )	15.5V
Booststrapped Voltage ( $V_{BST}$ )	$V_{IN} + 5V$
Junction Temperature ( $T_J$ )	$-40^{\circ}C \leq T_J \leq +125^{\circ}C$
Storage Temperature ( $T_S$ )	$-65^{\circ}C$ to $+150^{\circ}C$

**Operating Ratings<sup>(2)</sup>**

Supply Voltage ( $V_{IN}$ )	+3V to +14.5V
Output Voltage Range	0.8V to $V_{IN} \times D_{MAX}$
Package Thermal Resistance	
$\theta_{JA}$ 10-lead MSOP	180°C/W

**Electrical Characteristics<sup>(3)</sup>**

$T_J = 25^{\circ}C$ ,  $V_{IN} = 5V$ ; **bold** values indicate  $-40^{\circ}C < T_J < +125^{\circ}C$ ; unless otherwise specified.

Parameter	Condition	Min	Typ	Max	Units
Feedback Voltage Reference	( $\pm 1\%$ )	0.792	0.8	0.808	V
Feedback Voltage Reference	( $\pm 2\%$ over temp)	<b>0.784</b>	0.8	<b>0.816</b>	V
Feedback Bias Current			30	<b>100</b>	nA
Output Voltage Line Regulation			0.03		% / V
Output Voltage Load Regulation			0.5		%
Output Voltage Total Regulation	$3V \leq V_{IN} \leq 14.5V$ ; $1A \leq I_{OUT} \leq 10A$ ; ( $V_{OUT} = 2.5V$ ) <sup>(4)</sup>		0.6		%

**Oscillator Section**

Oscillator Frequency		450	500	550	kHz
Maximum Duty Cycle		92			%
Minimum On-Time <sup>(4)</sup>			30	<b>60</b>	ns

**Input and  $V_{DD}$  Supply**

PWM Mode Supply Current	$V_{CS} = V_{IN} - 0.25V$ ; $V_{FB} = 0.7V$ (output switching but excluding external MOSFET gate current.)		1.5	<b>3</b>	mA
Digital Supply Voltage ( $V_{DD}$ )	$V_{IN} \geq 6V$	4.7	5	5.3	V

**Error Amplifier**

DC Gain			70		dB
Transconductance			1		ms

**Soft-Start**

Soft-Start Current	After timeout of internal timer. See "Soft-Start" section.		8.5		$\mu A$
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**Current Sense**

CS Over Current Trip Point	$V_{CS} = V_{IN} - 0.25V$	160	200	240	$\mu A$
Temperature Coefficient ppm/ $^{\circ}C$			+1800		

**Output Fault Correction Thresholds**

Upper Threshold, $V_{FB\_OVT}$	(relative to $V_{FB}$ )		+3		%
Lower Threshold, $V_{FB\_UVT}$	(relative to $V_{FB}$ )		-3		%

**Notes:**

1. Absolute maximum ratings indicate limits beyond which damage to the component may occur. Electrical specifications do not apply when operating the device outside of its operating ratings. The maximum allowable power dissipation is a function of the maximum junction temperature,  $T_J(max)$ , the junction-to-ambient thermal resistance,  $\theta_{JA}$ , and the ambient temperature,  $T_A$ . The maximum allowable power dissipation will result in excessive die temperature, and the regulator will go into thermal shutdown.
2. Devices are ESD sensitive, handling precautions required.
3. Specification for packaged product only.
4. Guaranteed by design.

## Electrical Characteristics<sup>(5)</sup>

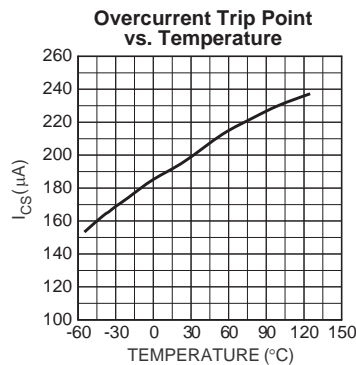
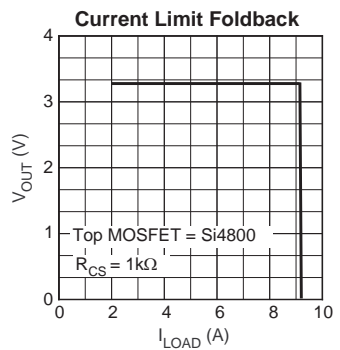
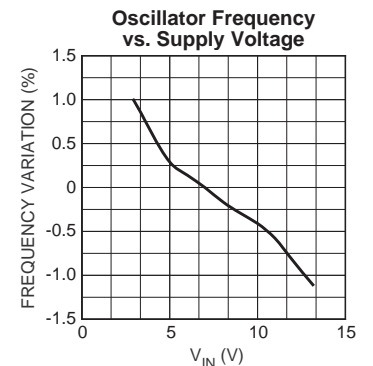
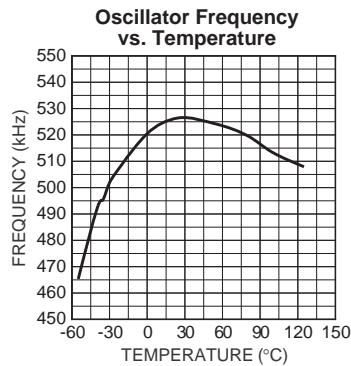
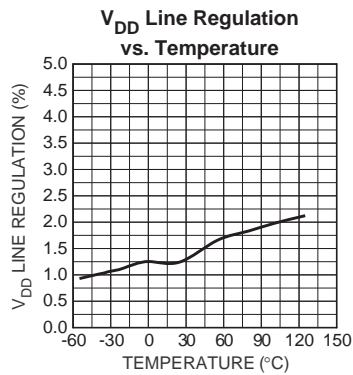
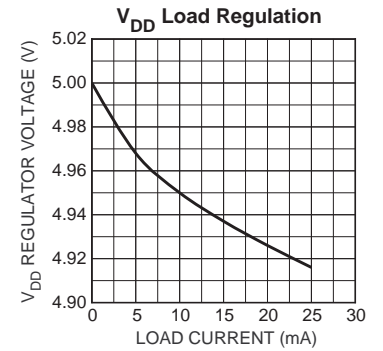
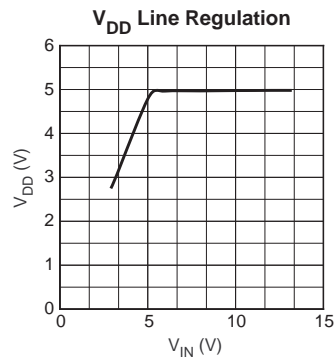
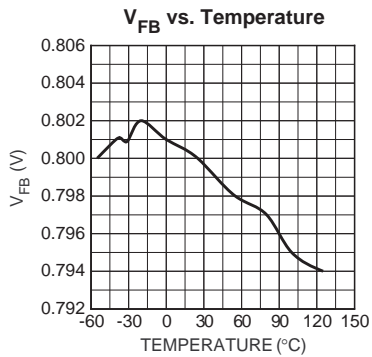
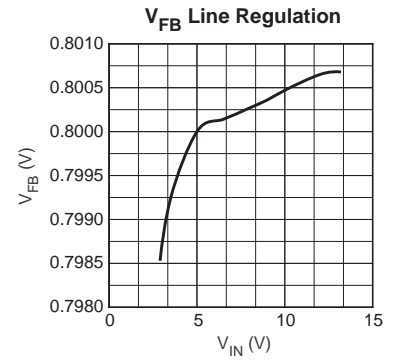
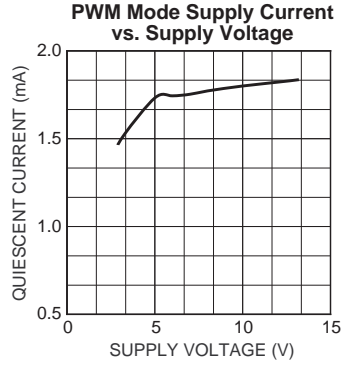
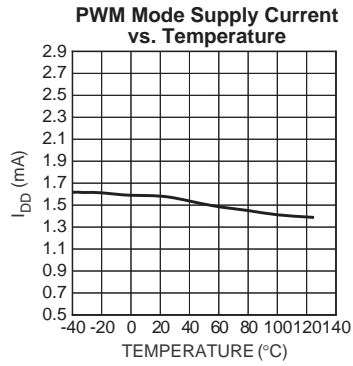
Parameter	Condition	Min	Typ	Max	Units
<b>Gate Drivers</b>					
Rise/Fall Time	Into 3000pF at $V_{IN} > 5V$		30		ns
Output Driver Impedance	Source, $V_{IN} = 5V$			6	$\Omega$
	Sink, $V_{IN} = 5V$			6	$\Omega$
	Source, $V_{IN} = 3V$			10	$\Omega$
	Sink, $V_{IN} = 3V$			10	$\Omega$
Driver Non-Overlap Time	<b>Note 6</b>	10	20		ns

### Notes:

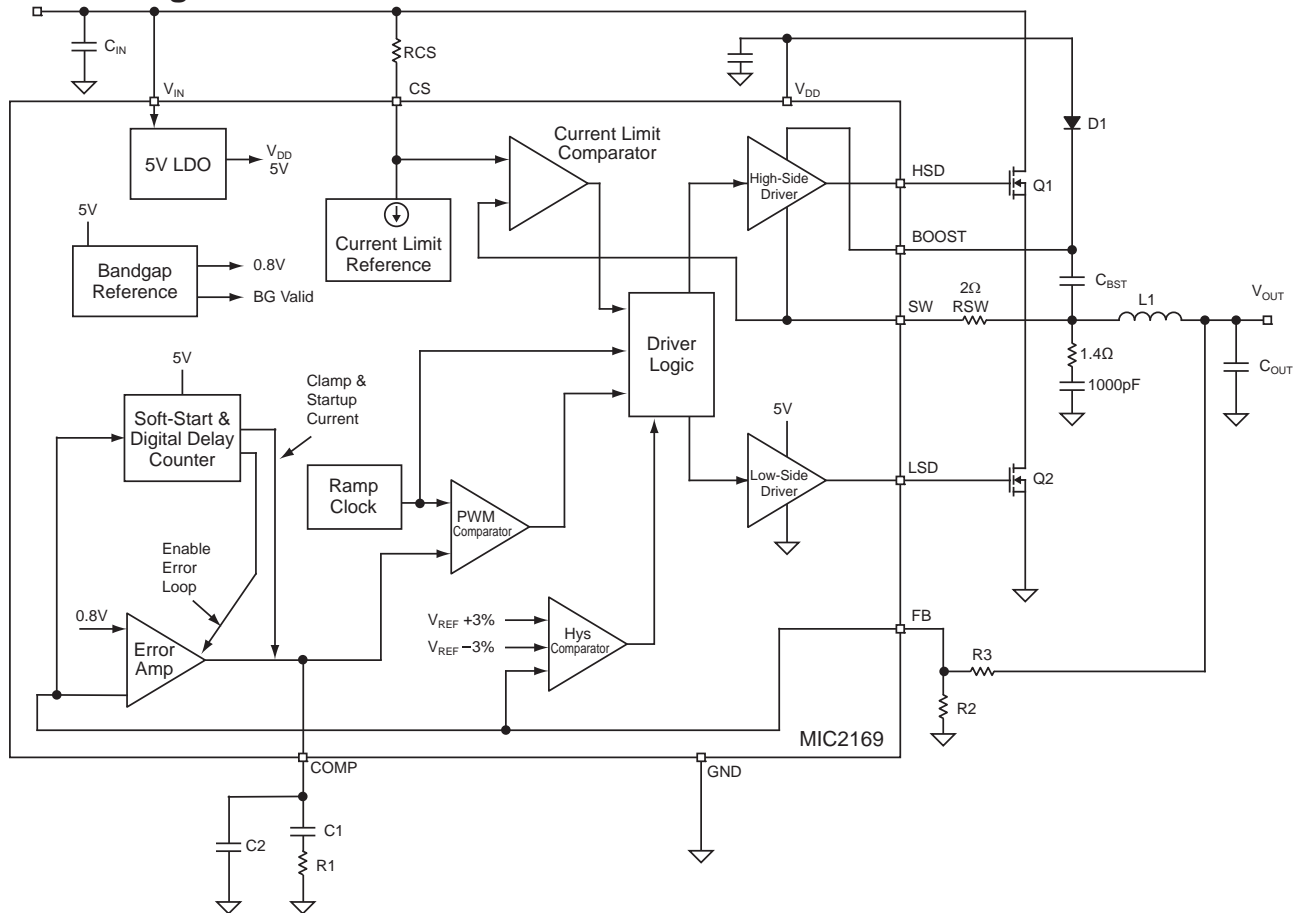
5. Specification for packaged product only.
6. Guaranteed by design.

# Typical Characteristics

$V_{IN} = 5V$



## Functional Diagram



MIC2169 Block Diagram

## Functional Description

The MIC2169 is a voltage mode, synchronous step-down switching regulator controller designed for high power without the use of an external sense resistor. It includes an internal soft-start function (which reduces the power supply input surge current at start-up by controlling the output voltage rise time), a PWM generator, a reference voltage, two MOSFET drivers, and short-circuit current limiting circuitry to form a complete 500kHz switching regulator.

### Theory of Operation

The MIC2169 is a voltage mode step-down regulator. The block diagram, above, illustrates the voltage control loop. The output voltage variation due, to load or line changes, will be sensed by the inverting input of the transconductance error amplifier via the feedback resistors R3, and R2 and compared to a reference voltage at the non-inverting input. This will cause a small change in the DC voltage level at the output of the error amplifier which is the input to the PWM comparator. The other input to the comparator is a 5V triangular waveform. The comparator generates a rectangular waveform whose width  $t_{ON}$  is equal to the time from the start of the clock cycle  $t_0$  until  $t_1$ , the time the triangle crosses the output waveform of the error amplifier. To illustrate the control loop, assume the output voltage drops due to sudden load turn-on, this would cause the inverting input of the error amplifier which is a divided down version of  $V_{OUT}$  to be slightly less than the reference

voltage. This causes the output voltage of the error amplifier to go high. This will also increase the PWM comparator  $t_{ON}$  time of the top side MOSFET, causing the output voltage to go up and bringing  $V_{OUT}$  back in regulation.

### Soft-Start

The COMP pin on the MIC2169 is used for the following two functions:

1. External compensation to stabilize the voltage control loop.
2. Soft-start.

For better understanding of the soft-start feature, assume  $V_{IN} = 12V$ . The COMP pin has an internal  $6.5\mu A$  current source that charges the external compensation capacitor. As soon as this voltage rises to 180mV ( $t = Cap\_COMP \times 0.18V / 8.5\mu A$ ), the MIC2169 allows the internal  $V_{DD}$  linear regulator to power up and as soon as it crosses the undervoltage lockout of 2.6V, the chip's internal oscillator starts switching. At this point, the COMP pin current source increases to  $40\mu A$  and an internal 11-bit counter starts counting. This takes approximately 2ms to complete. During counting, the COMP voltage is clamped at 0.65V. After this counting cycle, the COMP current source is reduced to  $8.5\mu A$  and the COMP pin voltage rises from 0.65V to 0.95V, the bottom edge of the saw-tooth oscillator. This is the beginning of 0% duty cycle which increases slowly causing the output voltage to rise slowly. The MIC2169 has

two hysteretic comparators that are enabled when  $V_{OUT}$  is within  $\pm 3\%$  of steady state. When the output voltage reaches 97% of programmed output voltage, then the  $g_m$  error amplifier is enabled along with the hysteretic comparator. From this point onwards, the voltage control loop ( $g_m$  error amplifier) is fully in control and will regulate the output voltage.

Soft-start time can be calculated approximately by adding the following four time frames:

$$t1 = \text{Cap\_COMP} \times 0.18\text{V}/8.5\mu\text{A}$$

$$t2 = 12 \text{ bit counter, approx } 2\text{ms}$$

$$t3 = \text{Cap\_COMP} \times 0.3\text{V}/8.5\mu\text{A}$$

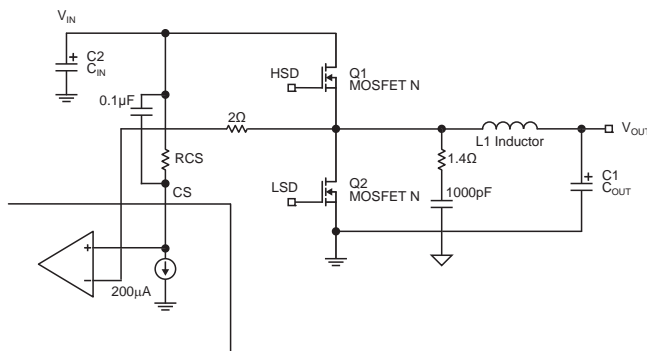
$$t4 = \left( \frac{V_{OUT}}{V_{IN}} \right) \times 0.5 \times \frac{\text{Cap\_COMP}}{8.5\mu\text{A}}$$

$$\text{Soft-Start Time}(\text{Cap\_COMP}=100\text{nF}) = t1 + t2 + t3 +$$

$$t4 = 2.1\text{ms} + 2\text{ms} + 3.5\text{ms} + 1.8\text{ms} = 10\text{ms}$$

### Current Limit

The MIC2169 uses the  $R_{DS(ON)}$  of the top power MOSFET to measure output current. Since it uses the drain to source resistance of the power MOSFET, it is not very accurate. However, this scheme is adequate to protect the power supply and external components during a fault condition by cutting back the time the top MOSFET is on if the feedback voltage is greater than 0.67V. In case of a hard short when feedback voltage is less than 0.67V, the MIC2169 discharges the COMP capacitor to 0.65V, resets the digital counter and automatically shuts off the top gate drive, and the  $g_m$  error amplifier and the  $-3\%$  hysteretic comparators are completely disabled and the soft-start cycles restarts. This mode of operation is called the "hiccup mode" and its purpose is to protect the down stream load in case of a hard short. The circuit in Figure 1 illustrates the MIC2169 current limiting circuit.



**Figure 1. The MIC2169 Current Limiting Circuit**

The current limiting resistor  $R_{CS}$  is calculated by the following equation:

$$R_{CS} = \frac{R_{DS(ON) Q1} \times I_L}{200\mu\text{A}} \quad \text{Equation (1)}$$

$$I_L = I_{LOAD} + \frac{1}{2(\text{Inductor Ripple Current})}$$

where:

$$\text{Inductor Ripple Current} =$$

$$V_{OUT} \times \frac{(V_{IN} - V_{OUT})}{V_{IN} \times F_{SWITCHING} \times L}$$

$$F_{SWITCHING} = 500\text{kHz}$$

$200\mu\text{A}$  is the internal sink current to program the MIC2169 current limit.

The MOSFET  $R_{DS(ON)}$  varies 30% to 40% with temperature; therefore, it is recommended that a 50% margin be added to the load current ( $I_{LOAD}$ ) in the above equation to avoid false current limiting due to increased MOSFET junction temperature rise. It is also recommended to connect the  $R_{CS}$  resistor directly to the drain of the top MOSFET Q1, and the  $R_{SW}$  resistor to the source of Q1 to accurately sense the MOSFETs  $R_{DS(ON)}$ . To make the MIC2169 insensitive to board layout and noise generated by the switch node. For this a  $1.4\Omega$  resistor and a  $1000\text{pF}$  capacitor is recommended between the switch node and ground. A  $0.1\mu\text{F}$  capacitor, in parallel with  $R_{CS}$ , should be connected to filter some of the switching noise.

### Internal $V_{DD}$ Supply

The MIC2169 controller internally generates  $V_{DD}$  for self biasing and to provide power to the gate drives. This  $V_{DD}$  supply is generated through a low-dropout regulator and generates 5V from  $V_{IN}$  supply greater than 5V. For supply voltage less than 5V, the  $V_{DD}$  linear regulator is approximately 200mV in dropout. Therefore, it is recommended to short the  $V_{DD}$  supply to the input supply through a  $5\Omega$  resistor for input supplies between 2.9V to 5V.

### MOSFET Gate Drive

The MIC2169 high-side drive circuit is designed to switch an N-Channel MOSFET. The block diagram on page 6 shows a bootstrap circuit, consisting of D1 and CBST. It supplies energy to the high-side drive circuit. Capacitor CBST is charged while the low-side MOSFET is on and the voltage on the VSW pin is approximately 0V. When the high-side MOSFET driver is turned on, energy from CBST is used to turn the MOSFET on. As the MOSFET turns on, the voltage on the VSW pin increases to approximately  $V_{IN}$ . Diode D1 is reversed biased and CBST floats high while continuing to keep the high-side MOSFET on. When the low-side switch is turned back on, CBST is recharged through D1. The drive voltage is derived from the internal 5V  $V_{DD}$  bias supply. The nominal low-side gate drive voltage is 5V and the nominal high-side gate drive voltage is approximately 4.5V due the voltage drop across D1. An approximate 20ns delay between the high- and low-side driver transition is used to prevent current from simultaneously flowing unimpeded through both MOSFETs.

### MOSFET Selection

The MIC2169 controller works from input voltages of 3V to 13.2V and has an internal 5V regulator to provide power to turn the external N-Channel power MOSFETs for high- and low-side switches. For applications where  $V_{IN} < 5\text{V}$ , the internal  $V_{DD}$  regulator operates in dropout mode, and it is necessary that the power MOSFETs used are sub-logic level and are in full conduction mode for  $V_{GS}$  of 2.5V. For applications when  $V_{IN} > 5\text{V}$ ; logic-level MOSFETs, whose operation is specified

at  $V_{GS} = 4.5V$  must be used.

It is important to note the on-resistance of a MOSFET increases with rising temperature. A  $75^{\circ}C$  rise in junction temperature will increase the channel resistance of the MOSFET by 50% to 75% of the resistance specified at  $25^{\circ}C$ . This change in resistance must be accounted for when calculating MOSFET power dissipation and in calculating the value of current-sense (CS) resistor. Total gate charge is the charge required to turn the MOSFET on and off under specified operating conditions ( $V_{DS}$  and  $V_{GS}$ ). The gate charge is supplied by the MIC2169 gate-drive circuit. At 500kHz switching frequency and above, the gate charge can be a significant source of power dissipation in the MIC2169. At low output load, this power dissipation is noticeable as a reduction in efficiency. The average current required to drive the high-side MOSFET is:

$$I_{G[\text{high-side}](\text{avg})} = Q_G \times f_S$$

where:

$I_{G[\text{high-side}](\text{avg})}$  = average high-side MOSFET gate current.

$Q_G$  = total gate charge for the high-side MOSFET taken from manufacturer's data sheet for  $V_{GS} = 5V$ .

The low-side MOSFET is turned on and off at  $V_{DS} = 0$  because the freewheeling diode is conducting during this time. The switching loss for the low-side MOSFET is usually negligible. Also, the gate-drive current for the low-side MOSFET is more accurately calculated using  $C_{ISS}$  at  $V_{DS} = 0$  instead of gate charge.

For the low-side MOSFET:

$$I_{G[\text{low-side}](\text{avg})} = C_{ISS} \times V_{GS} \times f_S$$

Since the current from the gate drive comes from the input voltage, the power dissipated in the MIC2169, due to gate drive, is:

$$P_{\text{GATEDRIVE}} = V_{IN} (I_{G[\text{high-side}](\text{avg})} + I_{G[\text{low-side}](\text{avg})})$$

A convenient figure of merit for switching MOSFETs is the on resistance times the total gate charge  $R_{DS(\text{ON})} \times Q_G$ . Lower numbers translate into higher efficiency. Low gate-charge logic-level MOSFETs are a good choice for use with the MIC2169.

Parameters that are important to MOSFET switch selection are:

- Voltage rating
- On-resistance
- Total gate charge

The voltage ratings for the top and bottom MOSFET are essentially equal to the input voltage. A safety factor of 20% should be added to the  $V_{DS(\text{max})}$  of the MOSFETs to account for voltage spikes due to circuit parasitics.

The power dissipated in the switching transistor is the sum of the conduction losses during the on-time ( $P_{\text{CONDUCTION}}$ ) and the switching losses that occur during the period of time when the MOSFETs turn on and off ( $P_{\text{AC}}$ ).

$$P_{\text{SW}} = P_{\text{CONDUCTION}} + P_{\text{AC}}$$

where:

$$P_{\text{CONDUCTION}} = I_{\text{SW}(\text{rms})}^2 \times R_{\text{SW}}$$

$$P_{\text{AC}} = P_{\text{AC}(\text{off})} + P_{\text{AC}(\text{on})}$$

$R_{\text{SW}}$  = on-resistance of the MOSFET switch

$$D = \text{duty cycle} \left( \frac{V_O}{V_{IN}} \right)$$

Making the assumption the turn-on and turn-off transition times are equal; the transition times can be approximated by:

$$t_T = \frac{C_{ISS} \times V_{GS} + C_{OSS} \times V_{IN}}{I_G}$$

where:

$C_{ISS}$  and  $C_{OSS}$  are measured at  $V_{DS} = 0$

$I_G$  = gate-drive current (1A for the MIC2169)

The total high-side MOSFET switching loss is:

$$P_{\text{AC}} = (V_{IN} + V_D) \times I_{\text{PK}} \times t_T \times f_S$$

where:

$t_T$  = switching transition time (typically 20ns to 50ns)

$V_D$  = freewheeling diode drop, typically 0.5V

$f_S$  is the switching frequency, nominally 500kHz

The low-side MOSFET switching losses are negligible and can be ignored for these calculations.

### Inductor Selection

Values for inductance, peak, and RMS currents are required to select the output inductor. The input and output voltages and the inductance value determine the peak-to-peak inductor ripple current. Generally, higher inductance values are used with higher input voltages. Larger peak-to-peak ripple currents will increase the power dissipation in the inductor and MOSFETs. Larger output ripple currents will also require more output capacitance to smooth out the larger ripple current. Smaller peak-to-peak ripple currents require a larger inductance value and therefore, a larger and more expensive inductor. A good compromise between size, loss and cost is to set the inductor ripple current to be equal to 20% of the maximum output current. The inductance value is calculated by the equation below.

$$L = \frac{V_{\text{OUT}} \times (V_{\text{IN}(\text{max})} - V_{\text{OUT}})}{V_{\text{IN}(\text{max})} \times f_S \times 0.2 \times I_{\text{OUT}(\text{max})}}$$

where:

$f_S$  = switching frequency, 500kHz

0.2 = ratio of AC ripple current to DC output current

$V_{\text{IN}(\text{max})}$  = maximum input voltage

The peak-to-peak inductor current (AC ripple current) is:

$$I_{\text{PP}} = \frac{V_{\text{OUT}} \times (V_{\text{IN}(\text{max})} - V_{\text{OUT}})}{V_{\text{IN}(\text{max})} \times f_S \times L}$$

The peak inductor current is equal to the average output current plus one half of the peak-to-peak inductor ripple current.

$$I_{PK} = I_{OUT(max)} + 0.5 \times I_{PP}$$

The RMS inductor current is used to calculate the  $I^2 \times R$  losses in the inductor.

$$I_{INDUCTOR(rms)} = I_{OUT(max)} \times \sqrt{1 + \frac{1}{3} \left( \frac{I_P}{I_{OUT(max)}} \right)^2}$$

Maximizing efficiency requires the proper selection of core material and minimizing the winding resistance. The high frequency operation of the MIC2169 requires the use of ferrite materials for all but the most cost sensitive applications. Lower cost iron powder cores may be used but the increase in core loss will reduce the efficiency of the power supply. This is especially noticeable at low output power. The winding resistance decreases efficiency at the higher output current levels. The winding resistance must be minimized although this usually comes at the expense of a larger inductor. The power dissipated in the inductor is equal to the sum of the core and copper losses. At higher output loads, the core losses are usually insignificant and can be ignored. At lower output currents, the core losses can be a significant contributor. Core loss information is usually available from the magnetics vendor. Copper loss in the inductor is calculated by the equation below:

$$P_{INDUCTORCu} = I_{INDUCTOR(rms)}^2 \times R_{WINDING}$$

The resistance of the copper wire,  $R_{WINDING}$ , increases with temperature. The value of the winding resistance used should be at the operating temperature:

$$R_{WINDING(hot)} = R_{WINDING(20^\circ C)} \times (1 + 0.0042 \times (T_{HOT} - T_{20^\circ C}))$$

where:

$T_{HOT}$  = temperature of the wire under operating load

$T_{20^\circ C}$  = ambient temperature

$R_{WINDING(20^\circ C)}$  is room temperature winding resistance (usually specified by the manufacturer)

### Output Capacitor Selection

The output capacitor values are usually determined capacitors ESR (equivalent series resistance). Voltage and RMS current capability are two other important factors to consider when selecting the output capacitor. Recommended capacitors are tantalum, low-ESR aluminum electrolytics, and POSCAPS. The output capacitor's ESR is usually the main cause of output ripple. The output capacitor ESR also affects the overall voltage feedback loop from stability point of view. See: "Feedback Loop Compensation" section for more information. The maximum value of ESR is calculated:

$$R_{ESR} \leq \frac{\Delta V_{OUT}}{I_{PP}}$$

where:

$V_{OUT}$  = peak-to-peak output voltage ripple

$I_{PP}$  = peak-to-peak inductor ripple current

The total output ripple is a combination of the ESR output capacitance. The total ripple is calculated below:

$$\Delta V_{OUT} = \sqrt{\left( \frac{I_{PP} \times (1-D)}{C_{OUT} \times f_S} \right)^2 + (I_{PP} \times R_{ESR})^2}$$

where:

D = duty cycle

$C_{OUT}$  = output capacitance value

$f_S$  = switching frequency

The voltage rating of capacitor should be twice the voltage for a tantalum and 20% greater for an aluminum electrolytic.

The output capacitor RMS current is calculated below:

$$I_{C_{OUT}(rms)} = \frac{I_{PP}}{\sqrt{12}}$$

The power dissipated in the output capacitor is:

$$P_{DISS(C_{OUT})} = I_{C_{OUT}(rms)}^2 \times R_{ESR(C_{OUT})}$$

### Input Capacitor Selection

The input capacitor should be selected for ripple current rating and voltage rating. Tantalum input capacitors may fail when subjected to high inrush currents, caused by turning the input supply on. To maximize reliability, tantalum input capacitor voltage rating should be at least two times the maximum input voltage. Aluminum electrolytic, OS-CON, and multilayer polymer film capacitors can handle the higher inrush currents without voltage derating. The input voltage ripple will primarily depend upon the input capacitor's ESR. The peak input current is equal to the peak inductor current, so:

$$\Delta V_{IN} = I_{INDUCTOR(peak)} \times R_{ESR(C_{IN})}$$

The input capacitor must be rated for the input current ripple. The RMS value of input capacitor current is determined at the maximum output current. Assuming the peak-to-peak inductor ripple current is low:

$$I_{C_{IN}(rms)} \approx I_{OUT(max)} \times \sqrt{D \times (1-D)}$$

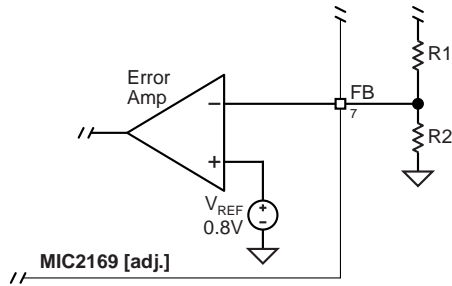
The power dissipated in the input capacitor is:

$$P_{DISS(C_{IN})} = I_{C_{IN}(rms)}^2 \times R_{ESR(C_{IN})}$$

### Voltage Setting Components

The MIC2169 requires two resistors to set the output voltage as shown in Figure 2.





**Figure 2. Voltage-Divider Configuration**

Where:

$V_{REF}$  for the MIC2169 is typically 0.8V

The output voltage is determined by the equation:

$$V_O = V_{REF} \times \left(1 + \frac{R1}{R2}\right)$$

A typical value of R1 can be between 3k $\Omega$  and 10k $\Omega$ . If R1 is too large, it may allow noise to be introduced into the voltage feedback loop. If R1 is too small, in value, it will decrease the efficiency of the power supply, especially at light loads. Once R1 is selected, R2 can be calculated using:

$$R2 = \frac{V_{REF} \times R1}{V_O - V_{REF}}$$

### External Schottky Diode

An external freewheeling diode is used to keep the inductor current flow continuous while both MOSFETs are turned off. This dead time prevents current from flowing unimpeded through both MOSFETs and is typically 15ns. The diode conducts twice during each switching cycle. Although the average current through this diode is small, the diode must be able to handle the peak current.

$$I_{D(avg)} = I_{OUT} \times 2 \times 15ns \times f_S$$

The reverse voltage requirement of the diode is:

$$V_{DIODE(rrm)} = V_{IN}$$

The power dissipated by the Schottky diode is:

$$P_{DIODE} = I_{D(avg)} \times V_F$$

where:

$V_F$  = forward voltage at the peak diode current

The external Schottky diode, D1, is not necessary for circuit operation since the low-side MOSFET contains a parasitic body diode. The external diode will improve efficiency and decrease high frequency noise. If the MOSFET body diode is used, it must be rated to handle the peak and average current. The body diode has a relatively slow reverse recovery time and a relatively high forward voltage drop. The power

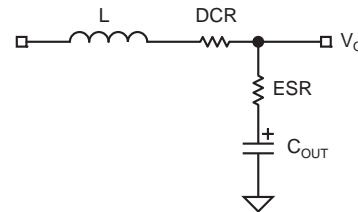
lost in the diode is proportional to the forward voltage drop of the diode. As the high-side MOSFET starts to turn on, the body diode becomes a short circuit for the reverse recovery period, dissipating additional power. The diode recovery and the circuit inductance will cause ringing during the high-side MOSFET turn-on. An external Schottky diode conducts at a lower forward voltage preventing the body diode in the MOSFET from turning on. The lower forward voltage drop dissipates less power than the body diode. The lack of a reverse recovery mechanism in a Schottky diode causes less ringing and less power loss. Depending upon the circuit components and operating conditions, an external Schottky diode will give a  $1/2\%$  to 1% improvement in efficiency.

### Feedback Loop Compensation

The MIC2169 controller comes with an internal transconductance error amplifier used for compensating the voltage feedback loop by placing a capacitor (C1) in series with a resistor (R1) and another capacitor C2 in parallel from the COMP pin-to-ground. See "Functional Block Diagram."

### Power Stage

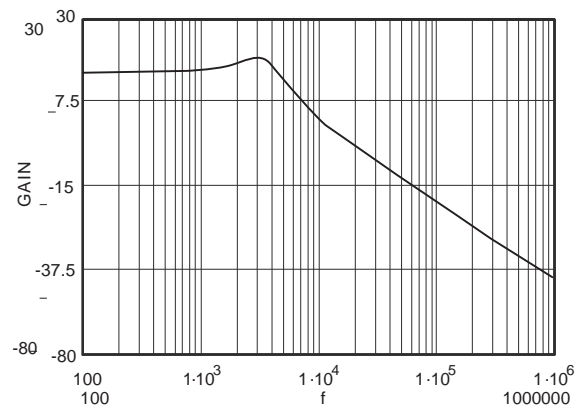
The power stage of a voltage mode controller has an inductor, L1, with its winding resistance (DCR) connected to the output capacitor,  $C_{OUT}$ , with its electrical series resistance (ESR) as shown in Figure 3. The transfer function G(s), for such a system is:



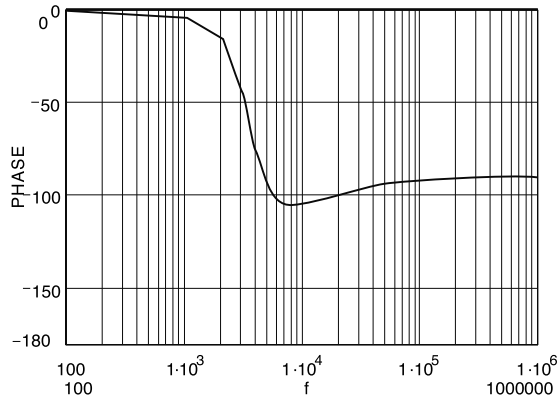
**Figure 3. The Output LC Filter in a Voltage Mode Buck Converter**

$$G(s) = \left( \frac{(1 + ESR \times s \times C)}{DCR \times s \times C + s^2 \times L \times C + 1 + ESR \times s \times C} \right)$$

Plotting this transfer function with the following assumed values ( $L=2 \mu\text{H}$ ,  $DCR=0.009\Omega$ ,  $C_{OUT}=1000\mu\text{F}$ ,  $ESR=0.025\Omega$ ) gives lot of insight as to why one needs to compensate the loop by adding resistor and capacitors on the COMP pin. Figures 4 and 5 show the gain curve and phase curve for the above transfer function.



**Figure 4. The Gain Curve for G(s)**



**Figure 5. Phase Curve for G(s)**

It can be seen from the transfer function G(s) and the gain curve that the output inductor and capacitor create a two pole system with a break frequency at:

$$f_{LC} = \frac{1}{2 \times \pi \times \sqrt{L \times C_{OUT}}}$$

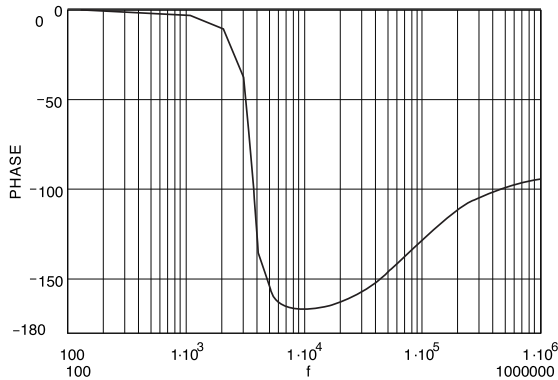
Therefore,  $f_{LC} = 3.6\text{kHz}$

By looking at the phase curve, it can be seen that the output capacitor ESR (0.025Ω) cancels one of the two poles (LC<sub>OUT</sub>) system by introducing a zero at:

$$f_{ZERO} = \frac{1}{2 \times \pi \times ESR \times C_{OUT}}$$

Therefore,  $F_{ZERO} = 6.36\text{kHz}$ .

From the point of view of compensating the voltage loop, it is recommended to use higher ESR output capacitors since they provide a 90° phase gain in the power path. For comparison purposes, Figure 6 shows the same phase curve with an ESR value of 0.002Ω.



**Figure 6. The Phase Curve with ESR = 0.002Ω**

It can be seen from Figure 5 that at 50kHz, the phase is approximately -90° versus Figure 6 where the number is -150°. This means that the transconductance error amplifier has to provide a phase boost of about 45° to achieve a closed-loop phase margin of 45° at a crossover frequency of 50kHz for Figure 4, versus 105° for Figure 6. The simple RC and C2 compensation scheme allows a maximum error amplifier phase boost of about 90°. Therefore, it is easier to stabilize the MIC2169 voltage control loop by using high ESR value output capacitors.

**g<sub>m</sub> Error Amplifier**

It is undesirable to have high error amplifier gain at high frequencies because high frequency noise spikes would be picked up and transmitted at large amplitude to the output, thus, gain should be permitted to fall off at high frequencies. At low frequency, it is desirable to have high open-loop gain to attenuate the power line ripple. Thus, the error amplifier gain should be allowed to increase rapidly at low frequencies.

The transfer function with R1, C1, and C2 for the internal g<sub>m</sub> error amplifier can be approximated by the following equation:

$$\text{Error Amplifier}(z) = g_m \times \left[ \frac{1 + R1 \times S \times C1}{s \times (C1 + C2) \left( 1 + R1 \times \frac{C1 \times C2 \times S}{C1 + C2} \right)} \right]$$

The above equation can be simplified by assuming  $C2 \ll C1$ ,

$$\text{Error Amplifier}(z) = g_m \times \left[ \frac{1 + R1 \times S \times C1}{s \times (C1) (1 + R1 \times C2 \times S)} \right]$$

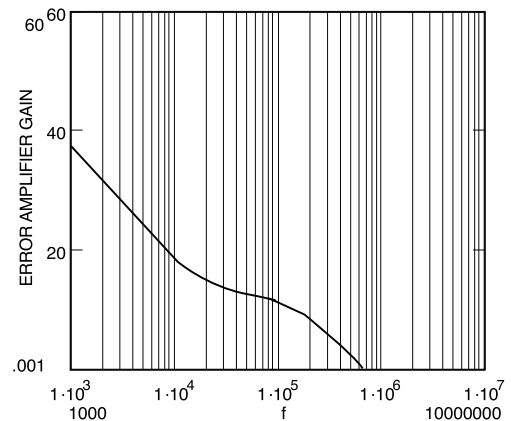
From the above transfer function, one can see that R1 and C1 introduce a zero and R1 and C2 a pole at the following frequencies:

$$F_{zero} = \frac{1}{2} \pi \times R1 \times C1$$

$$F_{pole} = \frac{1}{2} \pi \times C2 \times R1$$

$$F_{pole@origin} = \frac{1}{2} \pi \times C1$$

Figures 7 and 8 show the gain and phase curves for the above transfer function with R1 = 9.3k, C1 = 1000pF, C2 = 100pF, and g<sub>m</sub> = .005Ω<sup>-1</sup>. It can be seen that at 50kHz, the error amplifier exhibits approximately 45° of phase margin.



**Figure 7. Error Amplifier Gain Curve**

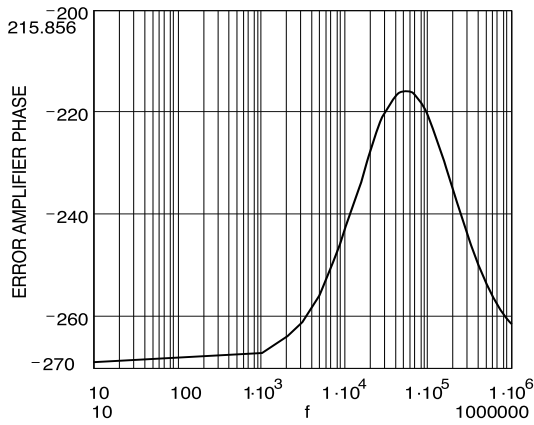


Figure 8. Error Amplifier Phase Curve

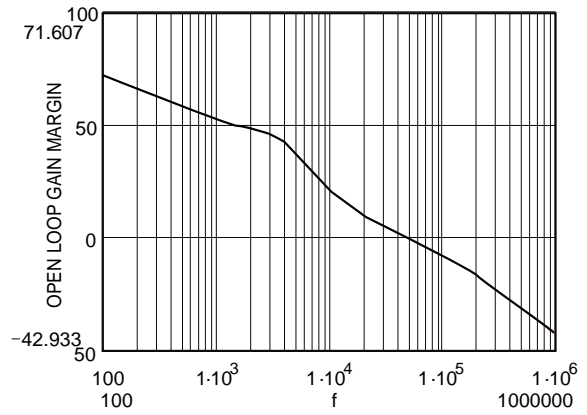


Figure 9. Open-Loop Gain Margin

**Total Open-Loop Response**

The open-loop response for the MIC2169 controller is easily obtained by adding the power path and the error amplifier gains together, since they already are in Log scale. It is desirable to have the gain curve intersect zero dB at tens of kilohertz, this is commonly called crossover frequency; the phase margin at crossover frequency should be at least 45°. Phase margins of 30° or less cause the power supply to have substantial ringing when subjected to transients, and have little tolerance for component or environmental variations. Figures 9 and 10 show the open-loop gain and phase margin. It can be seen from Figure 9 that the gain curve intersects the 0dB at approximately 50kHz, and from Figure 10, that at 50kHz, the phase shows approximately 50° of margin.

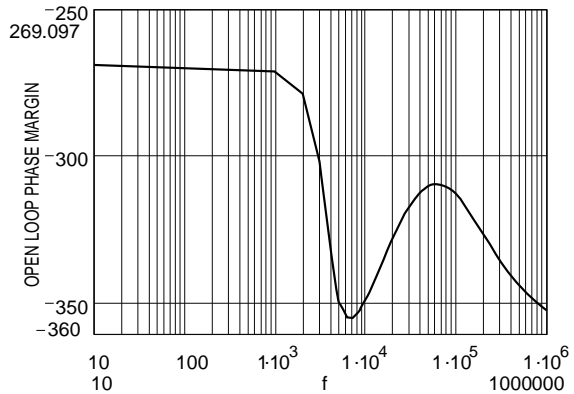
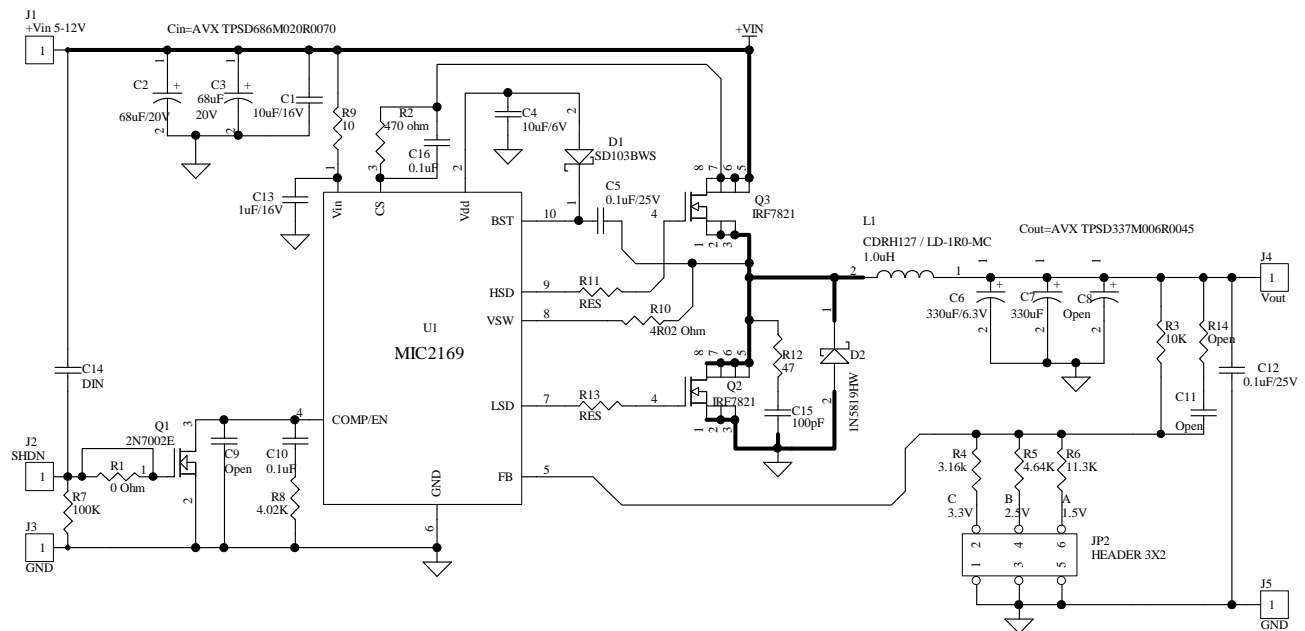


Figure 10. Open-Loop Phase Margin

## Design Example

### Layout and Checklist:

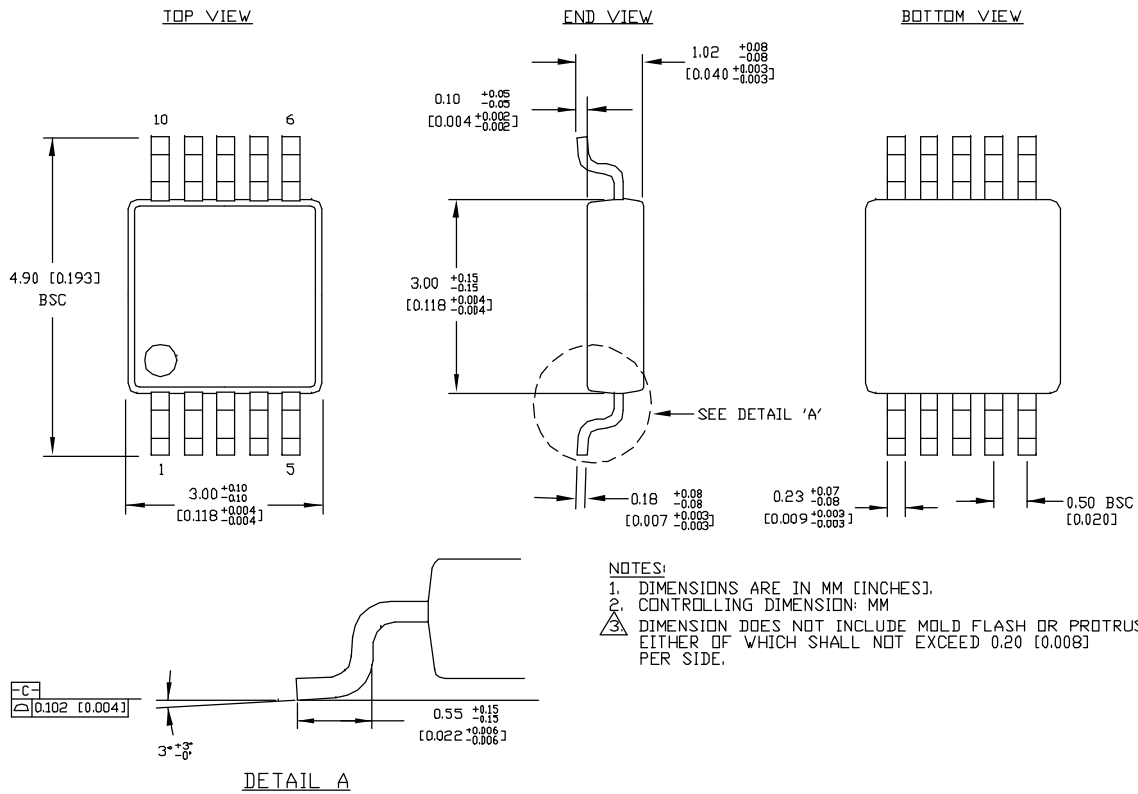
1. Connect the current limiting (R2) resistor directly to the drain of top MOSFET Q3.
2. Use a 5Ω resistor from the input supply to the VIN pin on the MIC2169. Also, place a 1μF ceramic capacitor from this pin to GND, preferably not thru a via.
3. The feedback resistors R3 and R4/R5/R6 should be placed close to the FB pin. The top side of R3 should connect directly to the output node. Run this trace away from the switch node (junction of Q3, Q2, and L1). The bottom side of R3 should connect to the GND pin on the MIC2169.
4. The compensation resistor and capacitors should be placed right next to the COMP pin and the other side should connect directly to the GND pin on the MIC2169 rather than going to the plane.
5. Add a 1.4Ω resistor and a 1000pF capacitor from the switch node to ground pin. See page 7, Current Limiting section for more detail.
6. Add place holders for gate resistors on the top and bottom MOSFET gate drives. If necessary, gate resistors of 10Ω or less should be used.
7. Low gate charge MOSFETs should be used to maximize efficiency, such as Si4800, Si4804BDY, IRF7821, IRF8910, FDS6680A and FDS6912A, etc.
8. Compensation component GND, feedback resistor ground, chip ground should all run together and connect to the output capacitor ground. See demo board layout, top layer.
9. The 10μF ceramic capacitor should be placed between the drain of the top MOSFET and the source of the bottom MOSFET.
10. The 10μF ceramic capacitor should be placed right on the VDD pin without any vias.
11. The source of the bottom MOSFET should connect directly to the input capacitor GND with a thick trace. The output capacitor and the input capacitor should connect directly to the GND plane.
12. Place a 0.01μF to 0.1μF ceramic capacitor in parallel with the CS resistor to filter any switching noise.



MIC2169BMM Evaluation Board Schematic



Package Information



10-Pin MSOP (MM)

MICREL, INC. 2180 FORTUNE DRIVE SAN JOSE, CA 95131 USA

TEL + 1 (408) 944-0800 FAX + 1 (408) 944-0970 WEB <http://www.micrel.com>

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